

2SC4989

NPN EPITAXIAL PLANAR TYPE

DESCRIPTION

2SC4989 is a silicon NPN epitaxial planar type transistor specifically designed for high power amplifiers in UHF band.

FEATURES

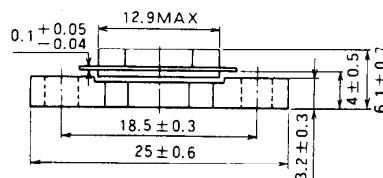
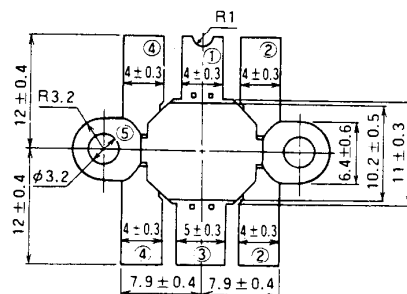
- High power output and high gain : $P_o \geq 65W$, $G_{pe} \geq 5.1dB$,
@ $V_{cc} = 12.5V$, $f = 520MHz$, $P_{in} = 20W$
- Emitter ballasted construction.
- Load mismatch : Ability to withstand more than 8 : 1 load
VSWR when operated at $V_{cc} = 15.2V$, $P_o = 65W$,
 $f = 520MHz$,
- High reliability due to gold metalization die.
- Flange type ceramic package.

APPLICATIONS

For output stage of 50W power amplifiers in UHF band.

OUTLINE DRAWING

Dimension in mm



- PIN :
- ① COLLECTOR
 - ② EMITTER (FLANGE)
 - ③ BASE
 - ④ EMITTER (FLANGE)
 - ⑤ FIN (EMITTER)

T-40E

ABSOLUTE MAXIMUM RATINGS (T_c = 25°C unless otherwise noted)

Symbol	Parameter	Conditions	Ratings	Unit
V _{CB0}	Collector-base voltage		35	V
V _{EB0}	Emitter-base voltage		4	V
V _{CE0}	Collector-emitter voltage	R _{BE} = ∞	17	V
I _c	Collector current		20	A
P _c	Collector dissipation		150	W
T _j	Junction temperature		175	°C
T _{stg}	Storage temperature		- 55 to 175	°C

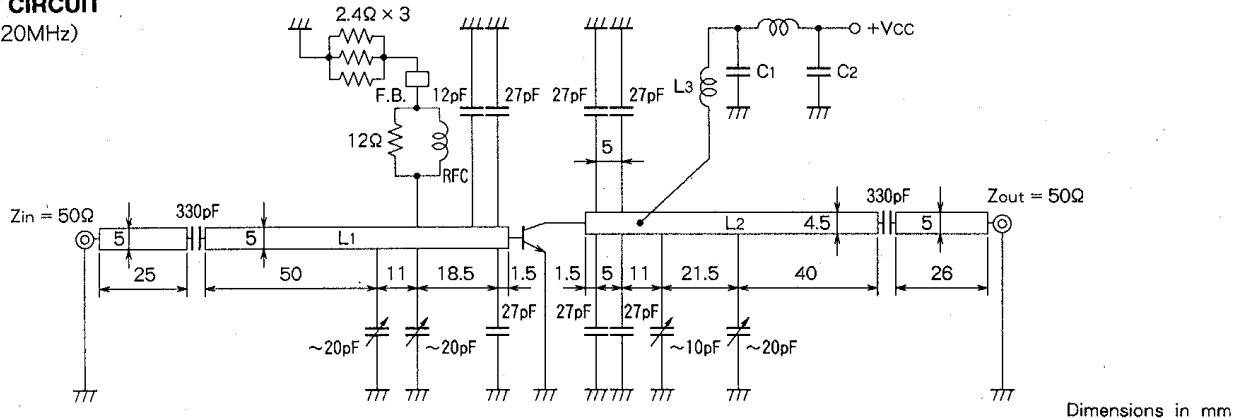
Note. Above parameters are guaranteed independently.

ELECTRICAL CHARACTERISTICS (T_c = 25°C unless otherwise noted)

Symbol	Parameter	Test conditions	Limits		Unit
			Min	Max	
V _{(BR)CBO}	Collector-base breakdown voltage	I _c = 20mA, I _E = 0	35		V
V _{(BR)EBO}	Emitter-base breakdown voltage	I _E = 20mA, I _c = 0	4		V
V _{(BR)CEO}	Collector-emitter breakdown voltage	I _c = 100mA, R _{BE} = ∞	17		V
I _{cBO}	Collector cutoff current	V _{CB} = 15V, I _E = 0		5	mA
I _{EBO}	Emitter cutoff current	V _{EB} = 3V, I _c = 0		5	mA
h _{FE}	DC forward current gain	V _{CE} = 5V, I _c = 5A	10	180	-
P _o	Output power	V _{cc} = 12.5V, f = 520MHz, P _{in} = 20W	65		W
η _c	Collector efficiency		55		%

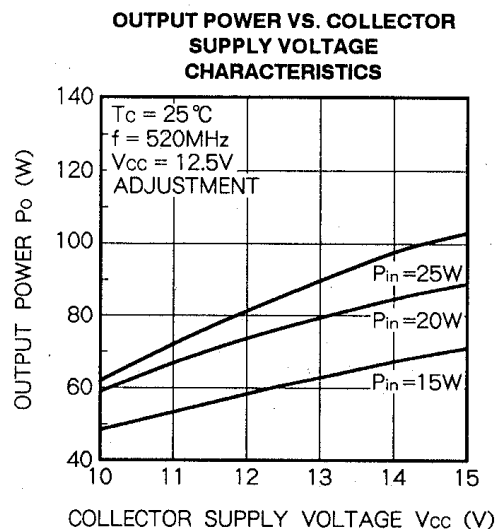
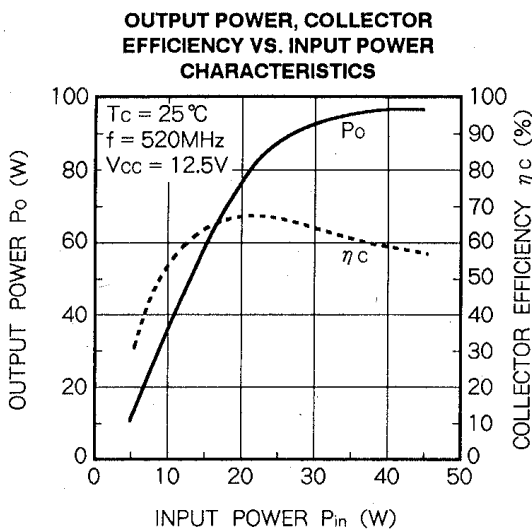
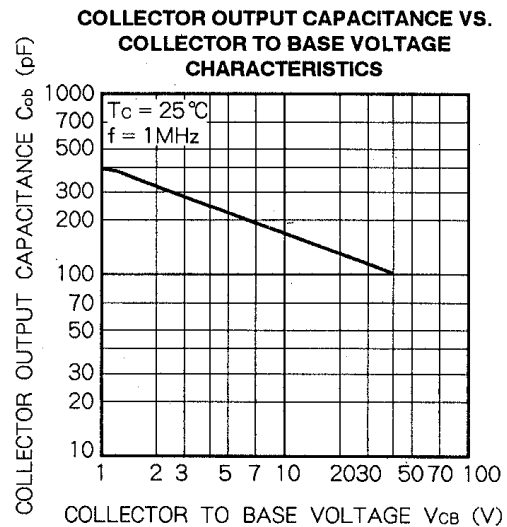
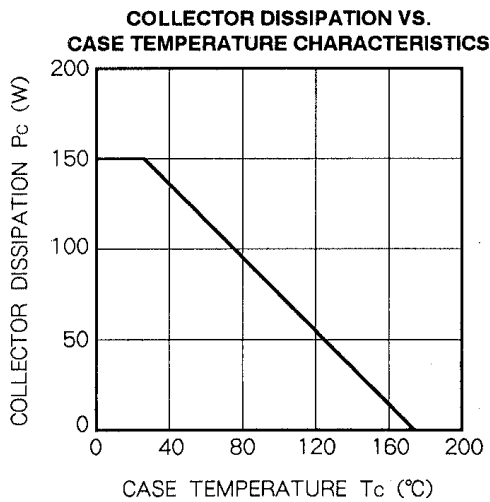
Note. Above parameters, ratings, limits and conditions are subject to change.

TEST CIRCUIT
(f = 520MHz)



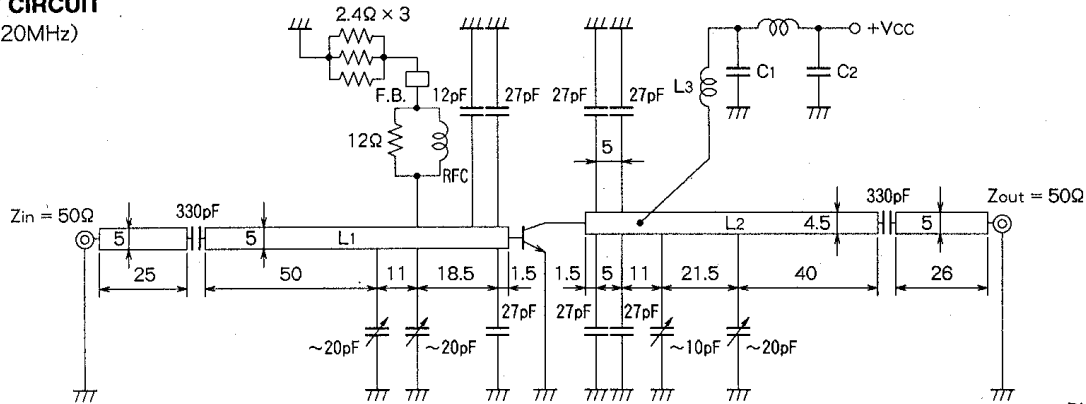
- L1, L2 : Microstrip : Board material 1.6mm thick, glass-epoxy $\epsilon_r = 2.6$
- L3 : 5D, 2Turn, 1P, $\phi 1.6$ mm silver plated copper wire
- L4 : 5D, 5Turn, 1P, $\phi 1.6$ mm silver plated copper wire
- RFC : 5D, 8Turn, 1P, $\phi 0.7$ mm enameled wire
- F.B : Ferrite Bead
- C1 : 47pF, 220pF, 2200pF, 2200 μ F in Paralleled
- C2 : 47pF, 220pF, 2200pF, 2200 μ F, 100 μ F

TYPICAL PERFORMANCE DATA



TEST CIRCUIT

(f = 520MHz)



Dimensions in mm

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TYPICAL PERFORMANCE DATA

